

N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^{a, e}	Q _g (Typ.)		
60	0.0113 at V _{GS} = 10 V	38	51nC		
60	0.0143 at $V_{GS} = 4.5 \text{ V}$	33	31110		

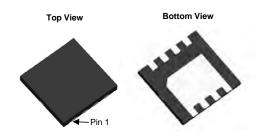
FEATURES

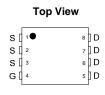
- TrenchFET® Power MOSFET
- 100 % R_g and UIS Tested

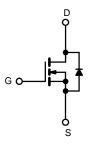
APPLICATIONS

- · Notebook PC Core
- VRM/POL

DFN 3x3 EP







N-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS} 60		V	
Gate-Source Voltage		V _{GS}	± 20		
	T _C = 25 °C		38 ^{a, e}		
Continuous Drain Current (T _J = 175 °C)	T _C = 70 °C	I _D	30 ^e	Α Α	
Continuous Diain Current (1) = 175 C)	T _A = 25 °C	'D	15 ^{b, c}		
	T _A = 70 °C		12.2 ^{b, c}		
Pulsed Drain Current		I _{DM}	114		
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	26		
Single Pulse Avalanche Energy	L=0.1 IIII	E _{AS}	50.2	mJ	
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	38 ^{a, e}	А	
Continuous Source-Drain Diode Current	T _A = 25 °C	'S	20 ^{b, c}	A	
	T _C = 25 °C		31.2	w	
Maximum Power Dissipation	T _C = 70 °C	P _D	20		
Maximum Power Dissipation	T _A = 25 °C	טי	3.55 ^{b, c}		
	T _A = 70 °C		2.13 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	31	44	°C/W
Maximum Junction-to-Case	Steady State	R _{thJC}	3	4	C/VV

Notes:

- a. Based on T_C = 25 °C. b. Surface mounted on 1" x 1" FR4 board.
- d. Maximum under steady state conditions is 90 °C/W.
- e. Calculated based on maximum junction temperature. Package limitation current is 80 A.



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Parameter	Symbol	Test Conditions	Min .	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	60			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA	35	35		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$	ι _D = 230 μΑ		- 5.5			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.0		3.0	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zoro Coto Voltogo Droin Current	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V		1			
Zero Gate Voltage Drain Current		V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C			10	μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	38			Α	
D : 0	В	V _{GS} = 10 V, I _D = 12 A		0.0113	0.0125		
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 9 \text{ A}$		0.0143	0.0158	Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 12 A		100		S	
Dynamic ^b			•				
Input Capacitance	C _{iss}			1516		pF	
Output Capacitance	C _{oss}	$V_{DS} = 12.5 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		998			
Reverse Transfer Capacitance	C _{rss}			936			
Total Gate Charge	Qg	V _{DS} = 15 V, V _{GS} = 10 V, I _D = 12 A		51		nC	
				41.5			
Gate-Source Charge	Q_{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 9 \text{ A}$		24			
Gate-Drain Charge	Q_{gd}			19			
Gate Resistance	R_g	f = 1 MHz		1.4	2.1	Ω	
Turn-On Delay Time	t _{d(on)}			18	27		
Rise Time	t _r	V_{DD} = 15 V, R_L = 0.555 Ω		11	17		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 7 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		70	105		
Fall Time	t _f			10	15		
Turn-On Delay Time	t _{d(on)}			55	83	ns	
Rise Time	t _r	V_{DD} = 15 V, R_L = 0.625 Ω		180	270		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 4 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		55	83		
Fall Time	t _f			12	18	<u> </u>	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			38	Α	
Pulse Diode Forward Current ^a	I _{SM}				114		
Body Diode Voltage	V _{SD}	I _S = 12 A		0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			52	78	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	$I_F = 10 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$		70.2	105	nC	
Reverse Recovery Fall Time	t _a	$I_F = 10 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, I_J = 25 \text{ °C}$		27		nc	
Reverse Recovery Rise Time	t _b			25		ns	

Notes:

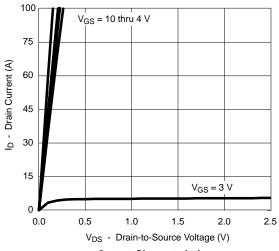
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

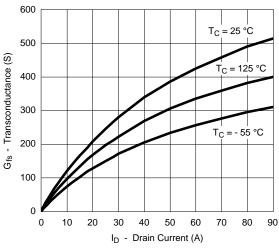


Din-Tek SEMICONDUCTOR

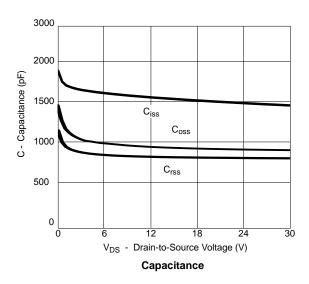
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

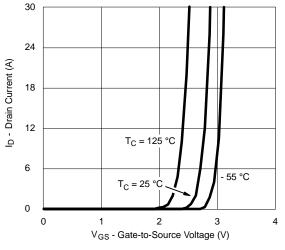


Output Characteristics

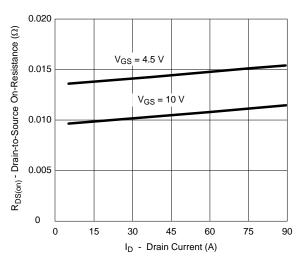


Transconductance

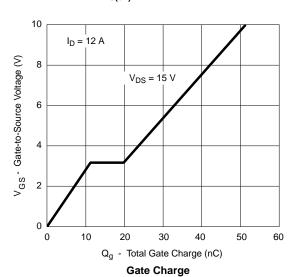




Transfer Characteristics

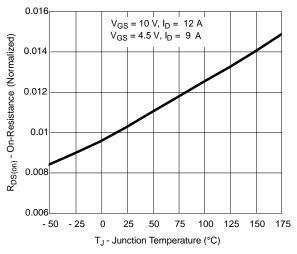


R_{DS(on)} vs. Drain Current

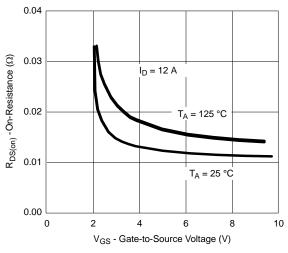




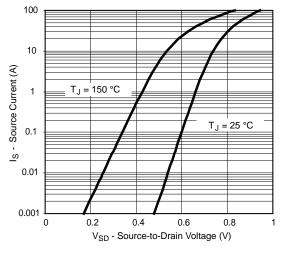
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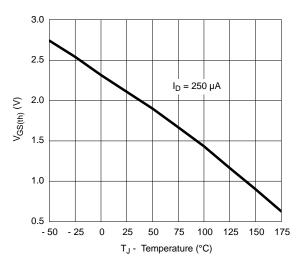
On-Resistance vs. Junction Temperature



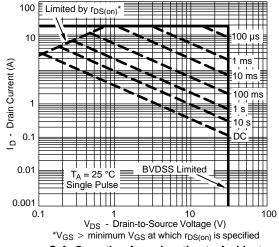
 $R_{DS(on)}$ vs. V_{GS} vs. Temperature



Forward Diode Voltage vs. Temperature



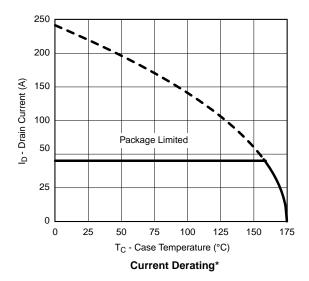
Threshold Voltage

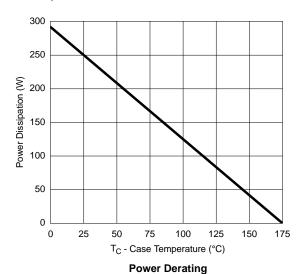




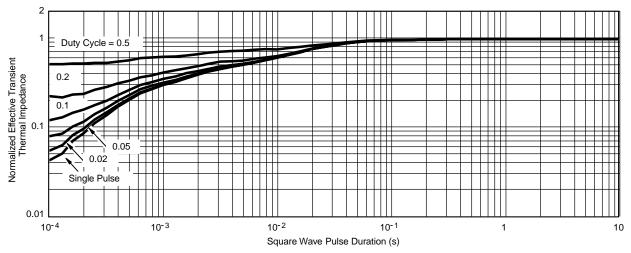


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

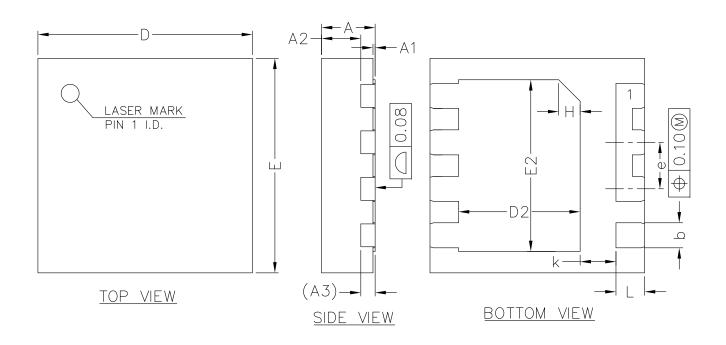


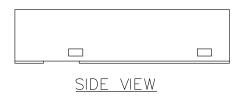


* The power dissipation P_D is based on $T_{J(max)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



Normalized Thermal Transient Impedance, Junction-to-Case





COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	NOM	MAX	
Α	0.70	0.75	0.80	
A1	0.00	0.02	0.05	
A2	0.50	0.55	0.60	
А3	0.20REF			
Ь	0.30	0.35	0.40	
D	2.90	3.00	3.10	
E	2.90	3.00	3.10	
D2	1.60	1.70	1.80	
E2	2.30	2.40	2.50	
е	0.55	0.65	0.75	
K	0.40	0.50	0.60	
L	0.35	0.40	0.45	





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